



Support & training



TDP2004 SNLS745 - NOVEMBER 2023

TDP2004 Four-Channel 20Gbps DisplayPort 2.1 Linear Redriver

1 Features

- Supports DisplayPort 2.1 up to 20Gbps RBR, HBRx, UHBRx
- Protocol agnostic linear equalizer supporting most AC coupled interfaces up to 20Gbps
- Excellent electrical performance at 20Gbps (10 GHz Nyquist):
 - 19 dB equalization
 - 1.8 V DC linearity, 1.08 V AC linearity
 - 15 / -16 dB Rx / Tx return loss
 - 60 dB NEXT, -43 dB FEXT cross talk
 - 70 fs low additive RJ with PRBS data
- Transparent to DisplayPort 1.4 and 2.1 link training
- Single 3.3 V supply with low active power: 160 mW / channel
- · Internal voltage regulator provides immunity to supply noise
- High linearity easing DP compliance ratio tests
- High channel BW resulting excellent linear EQ ٠ curves
- Pin-strap, I²C or EEPROM programming
 - 18 EQ boost settings
 - 5 flat gain settings
- TDP2004: 0 to 70 °C commercial temperature
- TDP2004I: -40 to 85 °C industrial temperature
- 4 mm × 6 mm, 40 pin WQFN package

2 Applications

- Desktop PC or motherboard •
- PC, notebooks, and tablets •
- Docking stations
- TV, gaming, home theater, and entertainment ٠
- Pro audio, video, and signage
- Test and measurement •
- Medical
- Flat panel monitors

3 Description

The TDP2004 is a four-channel low-power highperformance linear repeater or redriver designed to support DisplayPort 2.1 up to 20Gbps.

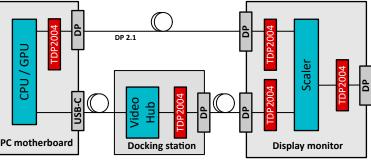
The TDP2004 receivers deploy continuous time linear equalizers (CTLE) to provide a programmable high-frequency boost. The equalizer can open an input eye that is completely closed due to intersymbol interference (ISI) induced by an interconnect medium, such as PCB traces. The CTLE receiver is followed by a linear output driver. The linear data-paths of TDP2004 preserve transmit preset signal characteristics. High bandwidth, low channelto- channel cross-talk, low additive jitter and excellent return loss makes the device almost a passive element in the link, but with its useful equalization. The DisplayPort link training is effective through the linear redriver that becomes part of the passive channel in between source Tx and sink Rx. This transparency in the link training protocol results in best electrical link and lowest possible latency. The data-path of the device uses an internally regulated power rail that provides high immunity to any supply noise on the board.

The device also has low AC and DC gain variation providing consistent equalization in high volume platform deployment.

Package mormation					
PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾			
TDP2004		1 mm x 6 mm			
TDP2004I	- RNQ (WQFN, 40)	4 11111 ^ 0 11111			

Bookage Information

- For more information, see Section 10. (1)
- The package size (length × width) is a nominal value and (2) includes pins, where applicable.



Typical Application





Table of Contents

1 Features	1
2 Applications	1
3 Description	1
4 Pin Configuration and Functions	3
5 Specifications	<mark>6</mark>
5.1 Absolute Maximum Ratings	<mark>6</mark>
5.2 ESD Ratings	<mark>6</mark>
5.3 Recommended Operating Conditions	6
5.4 Thermal Information	7
5.5 DC Electrical Characteristics	7
5.6 High Speed Electrical Characteristics	<mark>8</mark>
5.7 SMBUS/I ² C Timing Characteristics	
5.8 Typical Characteristics	10
5.9 Typical Jitter Characteristics	10
6 Detailed Description	11
6.1 Overview	11
6.2 Functional Block Diagram	11

6.3 Feature Description	11
6.4 Device Functional Modes	
6.5 Programming	. 13
7 Application and Implementation	17
7.1 Application Information	. 17
7.2 Typical Applications	
7.3 Power Supply Recommendations	19
7.4 Layout	20
8 Device and Documentation Support	21
8.1 Receiving Notification of Documentation Updates	21
8.2 Support Resources	21
8.3 Trademarks	21
8.4 Electrostatic Discharge Caution	21
8.5 Glossary	21
9 Revision History	21
10 Mechanical, Packaging, and Orderable	
Information	. 21



4 Pin Configuration and Functions

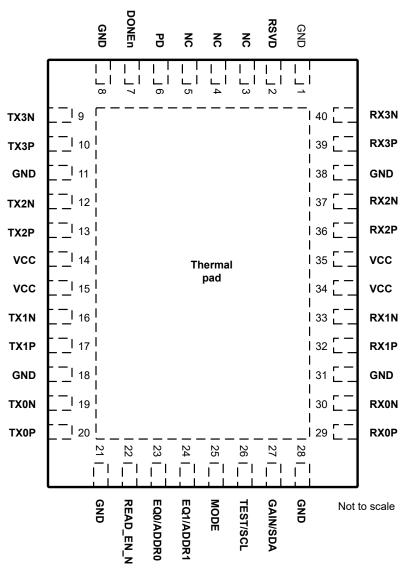


Figure 4-1. RNQ Package, 40-Pin WQFN (Top View)

Table 4-1. Pin Functions

PIN			DESCRIPTION
NAME	NO.		DESCRIPTION
DONEn	7	O, 3.3 V open drain	In SMBus /l ² C Primary mode : Indicates the completion of a valid EEPROM register load operation. External pullup resistor such as 4.7 k Ω required for operation. High: External EEPROM load failed or incomplete Low: External EEPROM load successful and complete In SMBus /l ² C Secondary/Pin mode : This output is High-Z. The pin can be left floating.

3

Table 4-1. Pin Functions (continued)

PIN		TYPE ⁽¹⁾			
NAME	NO.	ITPE(")	DESCRIPTION		
MODE	25	I, 5-level	Sets device control configuration modes. 5-level IO pin as provided in Table 6-3. The pin can be exercised at device power up or in normal operation mode. L0: Pin mode – device control configuration is done solely by strap pins. L1: SMBus/I²C Primary mode – device control configuration is read from external EEPROM. When the TDP2004 has finished reading from the EEPROM successfully, it will drive the DONEn pin LOW. SMBus/I ² C secondary operation is available in this mode before, during or after EEPROM reading. Note: during EEPROM reading if the external SMBus/I ² C primary wants to access TDP2004 registers it must support arbitration. L2: SMBus/I²C Secondary mode – device control configuration is done by an external controller with SMBus/I ² C primary. L3 and L4 (Float): RESERVED – TI internal test modes.		
EQ0 / ADDR0	23	I, 5-level	In Pin mode:		
EQ1 / ADDR1	24	l, 5-level	Sets receiver linear equalization (CTLE) boost for channels 0-3 as provided in Table 6-1. These pins are sampled at device power-up only. In SMBus/I²C mode: Sets SMBus / I ² C secondary address as provided in Table 6-4. These pins are sampled at device power-up only.		
GAIN / SDA	27	I, 5-level / I/O, 3.3 V LVCMOS, open drain	In Pin mode: Flat gain (DC and AC) from the input to the output of the device for channels 0-3. The pin is sampled at device power-up only. In SMBus/I²C mode: 3.3 V SMBus/I ² C data. External 1 k Ω to 5 k Ω pullup resistor is required as per SMBus / I ² C interface standard.		
GND	1, 8, 11, 18, 21, 28, 31, 38, EP	Ρ	Ground reference for the device. EP: the Exposed Pad at the bottom of the QFN package. It is used as the GND re for the device. The EP should be connected to one or more ground planes through low resistance path. A via array provides a low impedance path to GND. The EP a improves thermal dissipation.		
PD	6	I, 3.3 V LVCMOS	2-level logic controlling the operating state of the redriver. Active in all device control modes. The pin has internal 1-M Ω weak pull-down resistor. High: power down for channels 0-3 Low: power up, normal operation for channels 0-3		
READ_EN_N	22	I, 3.3 V LVCMOS	In SMBus/I²C Primary mode : After device power up, when the pin is low, it initiates the SMBus / I ² C Primary mode EEPROM read function. When EEPROM read is complete (indicated by assertion of DONEn low), this pin can be held low for normal device operation. During the EEPROM load process the device's signal path is disabled. In SMBus/I²C Secondary and Pin modes: In these modes the pin is not used. The pin can be left floating. The pin has internal 1-M Ω weak pull-down resistor.		
RSVD	2	_	Reserved use for TI. The pin must be left floating (NC).		
TEST / SCL	26	I, 5-level / I/O, 3.3 V LVCMOS, open drain	In Pin mode: TI test mode. External 1 k Ω pull down resistor must be installed. In SMBus/I²C mode: 3.3V SMBus/I ² C clock. External 1 k Ω to 5 k Ω pullup resistor is required as per SMBus / I ² C interface standard.		
RX0N	30	I	Inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 0.		
RX0P	29	I	Non-inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 0.		
RX1N	33	I	Inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 1.		
RX1P	32	I	Non-inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 1.		
RX2N	37	I	Inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 2.		



Table 4-1. Pin Functions (continued)

PIN		TYPE ⁽¹⁾	DESCRIPTION			
NAME	NO.	ITFE()	DESCRIPTION			
RX2P	36	Ι	Non-inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 2.			
RX3N	40	Ι	Inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor from the pin to internal CM bias voltage. Channel 3.			
RX3P	39	Ι	Non-inverting differential inputs to the equalizer. Integrated 50 Ω termination resistor rom the pin to internal CM bias voltage. Channel 3.			
TX0N	19	0	Inverting pin for 100 Ω differential driver output. Channel 0.			
TX0P	20	0	Non-inverting pin for 100 Ω differential driver output. Channel 0.			
TX1N	16	0	Inverting pin for 100 Ω differential driver output. Channel 1.			
TX1P	17	0	Non-inverting pin for 100 Ω differential driver output. Channel 1.			
TX2N	12	0	Inverting pin for 100 Ω differential driver output. Channel 2.			
TX2P	13	0	Non-inverting pin for 100 Ω differential driver output. Channel 2.			
TX3N	9	0	Inverting pin for 100 Ω differential driver output. Channel 3.			
ТХЗР	10	0	Non-inverting pin for 100 Ω differential driver output. Channel 3.			
VCC	14, 15, 34, 35	Ρ	Power supply pins. VCC = $3.3 \text{ V} \pm 10\%$. The VCC pins on this device should be connected through a low-resistance path to the board VCC plane. Install a decouplin capacitor to GND near each VCC pin.			

(1) I = input, O = output, P = power

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
VCC _{ABSMAX}	Supply voltage (VCC)	-0.5	4.0	V
VIO _{CMOS,ABSMAX}	3.3 V LVCMOS and open drain I/O voltage	-0.5	4.0	V
VIO _{5LVL,ABSMAX}	5-level input I/O voltage	-0.5	2.75	V
VIO _{HS-RX,ABSMAX}	High-speed I/O voltage (RXnP, RXnN)	-0.5	3.2	V
VIO _{HS-TX,ABSMAX}	High-speed I/O voltage (TXnP, TXnN)	-0.5	2.75	V
T _{J,ABSMAX}	Junction temperature		150	°C
T _{stg}	Storage temperature range	-65	150	°C

(1) Operation outside the Absolute Maximum Rating may cause permanent device damage. Absolute Maximum Rating do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Condition. If used outside the Recommended Operating Condition but within the Absolute Maximum Rating, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
V _(ESD)		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±2 kV may actually have higher performance.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage, VCC to GND	DC plus AC power should not exceed these limits	3.0	3.3	3.6	V
		DC to <50 Hz, sinusoidal ¹			250	mVpp
		50 Hz to 500 kHz, sinusoidal ¹			100	mVpp
N _{VCC}	Supply noise tolerance	500 kHz to 2.5 MHz, sinusoidal ¹			33	mVpp
		Supply noise, >2.5 MHz, sinusoidal ¹			10	mVpp
T _{RampVCC}	VCC supply ramp time	From 0 V to 3.0 V	0.150		100	ms
T	Operating ambient temperature	TDP2004	0		70	°C
T _A		TDP2004I	-40		85	°C
т		TDP2004			105	°C
Т _Ј	Operating junction temperature	TDP2004I			125	°C
PW _{LVCMOS}	Minimum pulse width required for the device to detect a valid signal on LVCMOS inputs	PD and READ_EN_N	200			μs
VCC _{SMBUS}	SMBus/I ² C SDA and SCL open drain termination voltage	Supply voltage for open drain pull-up resistor			3.6	V
F _{SMBus}	SMBus/I ² C clock (SCL) frequency	SMBus secondary mode	10		400	kHz
VID _{LAUNCH}	Source launch amplitude	Differential signaling			1200	mVpp
DR	Data rate		1		20	Gbps



5.4 Thermal Information

	THERMAL METRIC ⁽¹⁾	RNQ, 40 Pins	UNIT
R _{0JA-High K}	Junction-to-ambient thermal resistance	30.7	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	20.8	°C/W
R _{θJB}	Junction-to-board thermal resistance	11.4	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	0.3	°C/W
Ψјв	Junction-to-board characterization parameter	11.4	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	3.8	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report.

5.5 DC Electrical Characteristics

over operating free-air temperature and voltage range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power		· · · ·				
П	Device estive newer	4 channels active, EQ = 0-2		0.57	0.71	W
P _{ACT}	Device active power	4 channels active, EQ = 5-19		0.69	0.85	W
P _{STBY}	Device power consumption in standby power mode	All channels disabled (PD = H)		17	25	mW
Control IO		· · · · ·				
V _{IH}	High level input voltage	SDA, SCL, PD, READ_EN_N pins	2.1			V
V _{IL}	Low level input voltage	SDA, SCL, PD, READ_EN_N pins			1.08	V
V _{OH}	High level output voltage	$R_{pull-up} = 4.7 \text{ k}\Omega \text{ (SDA, SCL, DONEn}$ pins)	2.1			V
V _{OL}	Low level output voltage	I _{OL} = –4 mA (SDA, SCL, DONEn pins)			0.4	V
I _{IH}	Input high leakage current	V _{Input} = VCC, (SCL, SDA, PD, READ_EN_N pins)			10	μA
IIL	Input low leakage current	V _{Input} = 0 V, (SCL, SDA, PD, READ_EN_N pins)	-10			μA
I _{IH,FS}	Input high leakage current for fail safe input pins	V _{Input} = 3.6 V, VCC = 0 V, (SCL, SDA, , PD, READ_EN_N pins)			200	μA
C _{IN-CTRL}	Input capacitance	SDA, SCL, PD, READ_EN_N pins		1.6		pF
5 Level IOs	(MODE, GAIN, EQ0, EQ1 pins)	· · · · ·				
I _{IH_5L}	Input high leakage current, 5-level IOs	VIN = 2.5 V			10	μA
I _{IL_5L}	Input low leakage current for all 5-level IOs except MODE.	VIN = GND	-10			μA
I _{IL_5L,MODE}	Input low leakage current for MODE pin	VIN = GND	-200			μA
Receiver		· · · ·				
V _{RX-DC-CM}	RX DC common vode voltage	Device is in active or standby state		1.4		V
Z _{RX-DC}	Rx DC single-ended impedance			50		Ω
Transmitter	·	· · · · · · · · · · · · · · · · · · ·			L	
Z _{TX-DIFF-DC}	DC differential Tx impedance	Impedance of Tx during active signaling, VID,diff = 1 Vpp		100		Ω
V _{TX-DC-CM}	Tx DC common mode voltage			1.0		V
I _{TX-SHORT}	Tx short circuit current	Total current the Tx can supply when shorted to GND		70		mA



5.6 High Speed Electrical Characteristics

over operating free-air temperature and voltage range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
Receiver					
		3 GHz	-19		dB
		4 GHz	-18		dB
RL _{RX-DIFF}	Input differential return loss	5 GHz	-18		dB
		6 GHz	-17		dB
		10 GHz	-15		dB
XT _{RX}	Receiver-side pair-to-pair isolation; Port A or Port B	Minimum over 10 MHz to 10 GHz range	-60		dB
Transmitter					
RL _{TX-DIFF}	Output differential return loss	3 GHz	-19		dB
RL _{TX-DIFF}	Output differential return loss	4.0 GHz	-18		dB
RL _{TX-DIFF}	Output differential return loss	5.0 GHz	-18		dB
RL _{TX-DIFF}	Output differential return loss	6.0 GHz	-17		dB
RL _{TX-DIFF}	Output differential return loss	10 GHz	-16		dB
ХТ _{ТХ}	Transmit-side pair-to-pair isolation	Minimum over 10 MHz to 10 GHz range	-60		dB
Device Datap	bath	L I		I	
T _{PLHD/PHLD}	Input-to-output latency (propagation delay) through a data channel	For either low-to-high or high-to-low transition.	100	130	ps
L _{TX-SKEW}	Lane-to-lane output skew	Between any two lanes within a single transmitter.		20	ps
T _{RJ-DATA}	Additive random jitter with data	Jitter through redriver minus the calibration trace. 20Gbps PRBS15. 800 mVpp-diff input swing	70		fs
ХТ	Channel to channel xtalk (between adjacent active channels, FEXT	Minimum over 10 MHz to 10 GHz range, normalized to EQ gain of 0dB	-43		dB
		Minimum EQ, GAIN = L0	-5.6		dB
		Minimum EQ, GAIN = L1	-3.8		dB
FLAT-GAIN	Broadband DC and AC flat gain - input to output, measured at DC	Minimum EQ, GAIN = L2	-1.2		dB
		Minimum EQ, GAIN = L3	2.6		dB
		Minimum EQ, GAIN = L4 (Float)	0.6		dB
EQ-MAX _{10G}	EQ boost at max setting (EQ INDEX = 19)	AC gain at 10 GHz relative to gain at 100 MHz.	19		dB
LINEARITY- DC	Output DC linearity	at GAIN = L4	1750		mVpp
LINEARITY-		at 10Gbps, with GAIN = L4	1100		mVpp
AC	Output AC linearity	at 20Gbps, with GAIN = L4	1080		mVpp

5.7 SMBUS/I²C Timing Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Secondary	y Mode					
t _{SP}	Pulse width of spikes which must be suppressed by the input filter				50	ns
t _{HD-STA}	Hold time (repeated) START condition. After this period, the first clock pulse is generated		0.6			μs



5.7 SMBUS/I²C Timing Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	TEST CONDITIONS MIN T		MAX	UNIT
t _{LOW}	LOW period of the SCL clock		1.3			μs
T _{HIGH}	HIGH period of the SCL clock		0.6			μs
t _{SU-STA}	Set-up time for a repeated START condition		0.6			μs
t _{HD-DAT}	Data hold time		0			μs
T _{SU-DAT}	Data setup time		0.1			μs
t _r	Rise time of both SDA and SCL signals	Pull-up resistor = 4.7 k Ω , Cb = 10 pF		120		ns
t _f	Fall time of both SDA and SCL signals	Pull-up resistor = 4.7 k Ω , Cb = 10 pF		2		ns
t _{SU-STO}	Set-up time for STOP condition		0.6			μs
t _{BUF}	Bus free time between a STOP and START condition		1.3			μs
t _{VD-DAT}	Data valid time				0.9	μs
t _{VD-ACK}	Data valid acknowledge time				0.9	μs
C _b	Capacitive load for each bus line				400	pF
Primary Mo	de					
f _{SCL-M}	SCL clock frequency			303		kHz
t _{LOW-M}	SCL low period			1.90		μs
Т _{НІGН-М}	SCL high period			1.40		μs
t _{SU-STA-M}	Set-up time for a repeated START condition			2		μs
t _{HD-STA-M}	Hold time (repeated) START condition. After this period, the first clock pulse is generated			1.5		μs
T _{SU-DAT-M}	Data setup time			1.4		μs
t _{HD-DAT-M}	Data hold time			0.5		μs
t _{R-M}	Rise time of both SDA and SCL signals	Pull-up resistor = 4.7 k Ω , Cb = 10 pF		120		ns
T _{F-M}	Fall time of both SDA and SCL signals	Pull-up resistor = 4.7 k Ω , Cb = 10 pF		2		ns
t _{su-sто-м}	Stop condition setup time			1.5		μs
EEPROM T	iming					
T _{EEPROM}	EEPROM configuration load time	Time to assert DONEn after READ_EN_N has been asserted.		7.5		ms
T _{POR}	Time to first SMBus access	Power supply stable after initial ramp. Includes initial power-on reset time.		50		ms

-10

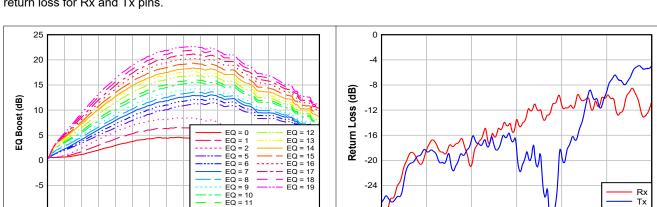
0 2 4 6 8 10 12



20

24

5.8 Typical Characteristics



14 16 18 20 22 24 26 28 30 32

Frequency (GHz)

Figure 5-1. Typical EQ Boost vs Frequency

Figure 5-1 shows typical EQ gain curves versus frequency for different EQ settings. Figure 5-2 shows typical differential return loss for Rx and Tx pins.

5.9 Typical Jitter Characteristics

Figure 5-3 and Figure 5-4 show eye diagrams at 20Gbps that compare jitter through calibration traces (left), and jitter through TDP2004 (right) at TI evaluation boards with minimal channels. The eye diagrams illustrate that TDP2004 adds very little random jitter (RJ).

-28

0

4

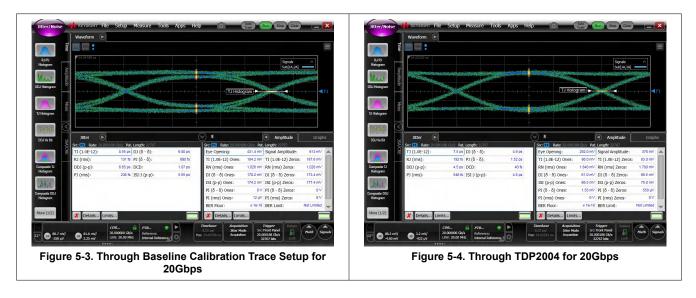
12

Frequency (GHz)

Figure 5-2. Typical Differential Return Loss

16

8





6 Detailed Description

6.1 Overview

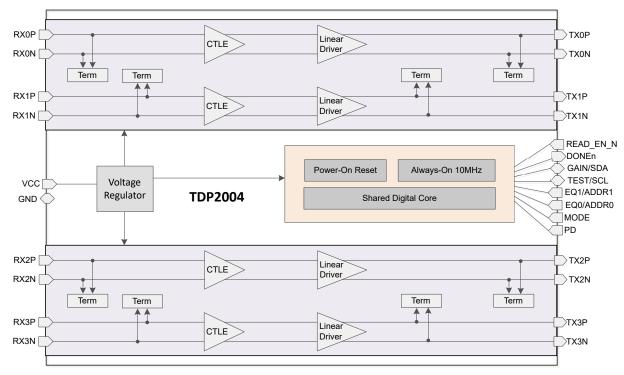
The TDP2004 is a four-channel multi-rate linear repeater with integrated signal conditioning. The device's signal channels operate independently from one another. Each channel includes a continuous-time linear equalizer (CTLE) and a linear output driver, which together compensate for a lossy transmission channel between the source transmitter and the final receiver. The linearity of the data path is specifically designed to preserve any transmit equalization while keeping receiver equalization effective.

The TDP2004 can be configured three different ways:

Pin mode – device control configuration is done solely by strap pins. Pin mode is expected to be good enough for many system implementation needs.

SMBus/I²C Primary mode – device control configuration is read from external EEPROM. When the TDP2004 has finished reading from the EEPROM successfully, it will drive the DONEn pin LOW. SMBus/I²C secondary operation is available in this mode before, during, or after EEPROM reading. Note: during EEPROM reading, if the external SMBus/I²C primary wants to access TDP2004 registers, then it must support arbitration. The mode is preferred when software implementation is not desired.

SMBus/I²C Secondary mode – provides most flexibility. Requires a SMBus/I²C primary device to configure TDP2004 though writing to its secondary address.



6.2 Functional Block Diagram

6.3 Feature Description

6.3.1 Linear Equalization

The TDP2004 receivers feature a continuous-time linear equalizer (CTLE) that applies high-frequency boost and low-frequency attenuation to help equalize the frequency-dependent insertion loss effects of the passive channel. The receivers implement two stage linear equalizer for wide range of equalization capability. The equalizer stages also provide flexibility to make subtle modifications of mid-frequency boost for best EQ gain profile match with wide range of channel media characteristics. The EQ profile control feature is only available in SMBus/I²C mode. In Pin mode the settings are optimized for FR4 traces.

Copyright © 2023 Texas Instruments Incorporated



Table 6-1 provides available equalization boost at 20Gbps (10 GHz Nyquist frequency) through EQ control pins or SMBus/I²C registers. In Pin Control mode EQ1 and EQ0 pins set equalization boost for channels 0-3. In I²C mode individual channels can be independently programmed for EQ boost. If the TDP2004 is used for other data rates equalization gain can be extracted from Figure 5-1.

	EQUALIZATION SETTING								
	Pin mode			SMBus/I	² C Mode				
EQ INDEX	EQ1	EQO	eq_stage1_3:0	eq_stage2_2:0	eq_profile_3:0	eq_stage1_bypass	at 10 GHz		
0	LO	LO	0	0	0	1	4.0		
1	LO	L1	1	0	0	1	5.0		
2	LO	L2	3	0	0	1	7.0		
5	L1	LO	0	0	1	0	8.0		
6	L1	L1	1	0	1	0	9.0		
7	L1	L2	2	0	1	0	9.5		
8	L1	L3	3	0	3	0	10.0		
9	L1	L4	4	0	3	0	11.0		
10	L2	LO	5	1	7	0	12.0		
11	L2	L1	6	1	7	0	12.5		
12	L2	L2	8	1	7	0	13.5		
13	L2	L3	10	1	7	0	14.5		
14	L2	L4	10	2	15	0	15.0		
15	L3	LO	11	3	15	0	15.5		
16	L3	L1	12	4	15	0	16.5		
17	L3	L2	13	5	15	0	17.0		
18	L3	L3	14	6	15	0	18.0		
19	L3	L4	15	7	15	0	19.0		

Table 6-1. Equalization Control Settings

6.3.2 Flat-Gain

The GAIN pin can be used to set the overall data-path flat gain (DC and AC) of the TDP2004 when the device is in Pin mode. The pin GAIN sets the Flat-Gain for channels 0-3. In I²C mode each channel can be independently set. Table 6-2 provides flat gain control configuration settings. In the default recommendation for most systems will be GAIN = L4 (float) that provides flat gain of 0 dB.

The flat-gain and equalization of the TDP2004 must be set such that the output signal swing at DC and high frequency does not exceed the DC and AC linearity ranges of the devices, respectively.

Pin mode GAIN	I ² C Modeflat_gain_2:0	Flat Gain						
LO	0	-5.6 dB						
L1	1	-3.8 dB						
L2	3	-1.2 dB						
L4 (float)	5	0.6 dB (default recommendation)						
L3	7	+2.6 dB						

Table 6-2. Flat Gain Configuration Settings



6.4 Device Functional Modes

6.4.1 Active Mode

The device is in normal operation. In this mode, the TDP2004 redrives and equalizes video mainlink signals to provide better signal integrity.

6.4.2 Standby Mode

The device is in standby mode invoked by PD = H. In this mode, the device is in standby mode conserving power.

6.5 Programming

6.5.1 Pin mode

The TDP2004 can be fully configured through pin-strap pins. In this mode the device uses 2-level and 5-level pins for device control and signal integrity optimum settings.

6.5.1.1 Five-Level Control Inputs

The TDP2004 has four (EQ0, EQ1, GAIN, and MODE) 5-level input pins that are used to control the configuration of the device. These 5-level inputs use a resistor divider to help set the 5 valid levels and provide a wider range of control settings. External resistors must be of 10% tolerance or better. The 5-level pins except MODE are sampled at power-up only. The MODE pin can be exercised at device power up or in normal operation mode.

Table 0-3: 3-level control Fill Settings						
LEVEL	SETTING					
LO	1 kΩ to GND					
L1	8.25 kΩ to GND					
L2	24.9 kΩ to GND					
L3	75 kΩ to GND					
L4	F (Float)					

Table 6-3. 5-level Control Pin Settings

6.5.2 SMBUS/I²C Register Control Interface

If MODE = L2 (SMBus/I²C Secondary control mode), then the TDP2004 is configured through a standard I²C or SMBus interface that may operate up to 400 kHz. The secondary address of the TDP2004 is determined by the pin strap settings on the ADDR1 and ADDR0 pins. The sixteen possible secondary addresses for channels 0-3 are provided in Table 6-4. In SMBus/I²C modes the SCL and SDA pins must be pulled up to a 3.3 V supply with a pull-up resistor. The value of the resistor depends on total bus capacitance. 4.7 k Ω is a good first approximation for a bus capacitance of 10 pF.

ADDR1	ADDR0	7-bit Secondary Address Channels 0-3
LO	LO	0x18
LO	L1	0x1A
LO	L2	0x1C
LO	L3	0x1E
LO	L4	Reserved
L1	LO	0x20
L1	L1	0x22
L1	L2	0x24
L1	L3	0x26
L1	L4	Reserved
L2	LO	0x28
L2	L1	0x2A

Table 6-4. SMBUS/I2C Secondary Address Settings

Copyright © 2023 Texas Instruments Incorporated



Table 6-4. SMBUS/I2C Secondary Address Settings (continued)

ADDR1	ADDR0	7-bit Secondary Address Channels 0-3						
L2	L2	0x2C						
L2	L3	0x2E						
L2	L4	Reserved						
L3	LO	0x30						
L3	L1	0x32						
L3	L2	0x34						
L3	L3	0x36						
L3	L4	Reserved						

The TDP2004 has two types of registers:

- **Shared Registers:** these registers can be accessed at any time and are used for device-level configuration, status read back, control, or to read back the device ID information.
- **Channel Registers:** these registers are used to control and configure specific features for each individual channel. All channels have the same register set and can be configured independent of each other or configured as a group through broadcast writes to Channels 0-3

Channel Registers Base Address	Channel 0-3 Access
0x00	Channel 0 registers
0x20	Channel 1 registers
0x40	Channel 2 registers
0x60	Channel 3 registers
0x80	Broadcast write channel 0-3 registers, read channel 0 registers
0xA0	Broadcast write channel 0-1 registers, read channel 0 registers
0xC0	Broadcast write channel 2-3 registers, read channel 2 registers
0xE0	Channel 0-3 share registers

6.5.2.1 Shared Registers

Table 6-5. General Registers (Offset = 0xE2)

Bit	Field	Туре	Reset	Description
7	RESERVED	R	0x0	Reserved
6	rst_i2c_regs	R/W/SC	0x0	Device reset control: Reset all I ² C registers to default values (self-clearing).
5	rst_i2c_mas	R/W/SC	0x0	Reset I ² C Primary (self-clearing).
4-1	RESERVED	R	0x0	Reserved
0	frc_eeprm_rd	R/W/SC	0x0	Override MODE and READ_EN_N status to force manual EEPROM configuration load.

Table 6-6. EEPROM_Status Register (Offset = 0xE3)

Bit	Field	Туре	Reset	Description
7	eecfg_cmplt	R	0x0	EEPROM load complete.
6	eecfg_fail	R	0x0	EEPROM load failed.
5	eecfg_atmpt_1	R	0x0	Number of attempts made to load EEPROM image.
4	eecfg_atmpt_0	R	0x0	see MSB
3	eecfg_cmplt	R	0x0	EEPROM load complete 2.
2	eecfg_fail	R	0x0	EEPROM load failed 2.
1	eecfg_atmpt_1	R	0x0	Number of attempts made to load EEPROM image 2.
0	eecfg_atmpt_0	R	0x0	see MSB



	Table 6-7. DEVICE_ID0 Register (Offset = 0xF0)							
Bit	Field	Туре	Reset	Description				
7-4	RESERVED	R	0x0	Reserved				
3	device_id0_3	R	0x0	Device ID0 [3:1]: 011				
2	device_id0_2	R	0x1	see MSB				
1	device_id0_1	R	0x1	see MSB				
0	RESERVED	R	X	Reserved				

Table 6-8. DEVICE_ID1 Register (Offset = 0xF1)

Bit	Field	Туре	Reset	Description	
7	device_id[7]	R	0x0	Device ID 0010 1001: TDP2004	
6	device_id[6]	R	0x0	see MSB	
5	device_id[5]	R	0x1	see MSB	
4	device_id[4]	R	0x0	see MSB	
3	device_id[3]	R	0x1	see MSB	
2	device_id[2]	R	0x0	see MSB	
1	device_id[1]	R	0x0	see MSB	
0	device_id[0]	R	0x0	see MSB	

6.5.2.2 Channel Registers

Table 6-9. EQ Gain Control Register (Channel register base + Offset = 0x01)

Bit	Field	Туре	Reset	Description
7	eq_stage1_bypass	R/W	0x0	Enable EQ stage 1 bypass:
				0: Bypass disabled
				1: Bypass enabled
6	eq_stage1_3	R/W	0x0	EQBoost stage 1 control
5	eq_stage1_2	R/W	0x0	See Table 6-1 for details
4	eq_stage1_1	R/W	0x0	
3	eq_stage1_0	R/W	0x0	
2	eq_stage2_2	R/W	0x0	EQ Boost stage 2 control
1	eq_stage2_1	R/W	0x0	See Table 6-1 for details
0	eq_stage2_0	R/W	0x0	

Table 6-10. EQ Gain / Flat Gain Control Register (Channel register base + Offset = 0x03)

Bit	Field	Туре	Reset	Description
7	RESERVED	R	0x0	Reserved
6	eq_profile_3	R/W	0x0	EQ mid-frequency boost profile
5	eq_profile_2	R/W	0x0	See Table 6-1 for details
4	eq_profile_1	R/W	0x0	
3	eq_profile_0	R/W	0x0	
2	flat_gain_2	R/W	0x1	Flat gain select:
1	flat_gain_1	R/W	0x0	See Table 6-2 for details
0	flat_gain_0	R/W	0x1	

Table 6-11. TI Test Mode Control Register (Channel register base + Offset = 0x04)

Bit	Field	Туре	Reset	Description
7-3, 1-0	RESERVED	R	0x0	Reserved

Copyright © 2023 Texas Instruments Incorporated



Table 6-11. TI Test Mode Control Register (Channel register base + Offset = 0x04) (continued)

Bit	Field	Туре	Reset	Description
2	TI test mode	R/W	0x0	Set TI test mode:
				0: test mode is enabled
				1: test mode is disabled. Must be set to "1" for normal operation.

Table 6-12. PD Override Register (Channel register base + Offset = 0x05)

Bit	Field	Туре	Reset	Description
7	device_en_override	R/W	0x0	Enable power down overrides through SMBus/I ² C 0: Manual override disabled 1: Manual override enabled
6-0	device_en	R/W	0x111111	Manual power down of redriver various blocks of a channel – gated by device_en_override = 1 111111: All blocks in the channel are enabled 000000: All blocks in the channel are disabled

Table 6-13. Bias Register (Channel register base + Offset = 0x06)

Bit	Field	Туре	Reset	Description						
5-3	Bias current	R/W		Control bias current Set 001 for best performance						
7,6,2-0	Reserved	R/W	0x00000	Reserved						

6.5.3 SMBus/I²C Primary Mode Configuration (EEPROM Self Load)

The TDP2004 can also be configured by reading from EEPROM. To enter into this mode MODE pin must be set to L1. The EEPROM load operation only happens once after the device's initial power-up. If the TDP2004 is configured for SMBus Primary mode, then it will remain in the SMBus IDLE state until the READ_EN_N pin is asserted to LOW. After the READ_EN_N pin is driven LOW, theTDP2004 becomes an SMBus primary and attempts to self-configure by reading the device settings stored in an external EEPROM (SMBus 8-bit address 0xA0). When the TDP2004 has finished reading from the EEPROM successfully, it will drive the DONEn pin LOW. SMBus/I²C secondary operation is available in this mode before, during, or after EEPROM reading. Note: during EEPROM reading, if the external SMBus/I²C primary wants to access TDP2004 registers, then it must support arbitration.

When designing a system for using the external EEPROM, the user must follow these specific guidelines:

- EEPROM size of 2Kb (256 × 8-bit) is recommended.
- Set MODE = L1, configure for SMBus Primary mode.
- The external EEPROM device address byte must be 0xA0 and capable of 400 kHz operation at 3.3 V supply
- In SMBus/I²C modes the SCL and SDA pins must be pulled up to a 3.3 V supply with a pull-up resistor. The value of the resistor depends on total bus capacitance. 4.7 kΩ is a good first approximation for a bus capacitance of 10 pF.

Multiple TDP2004 can be cascaded to read from single EEPROM. Tie the READ_EN_N pin of the first device low (GND) to automatically initiate EEPROM read at power up. DONEn of the first device can be fed into READ_EN_N of the next device with 4.7k pull-up resistors. Leave the DONEn pin of the final device floating, or connect the pin to a micro-controller input to monitor the completion of the final EEPROM read.



7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

The TDP2004 is a high-speed linear repeater which extends the reach of differential channels impaired by loss from transmission media like PCBs and cables. It can be deployed in a variety of different systems. The following sections outline typical applications and their associated design considerations.

7.2 Typical Applications

The TDP2004 is a linear redriver that can be used as DisplayPort mainlink signal conditioner. The device can be used in wide range of AC coupled interfaces including DisplayPort 1.4, 2.1 up to 20Gbps.

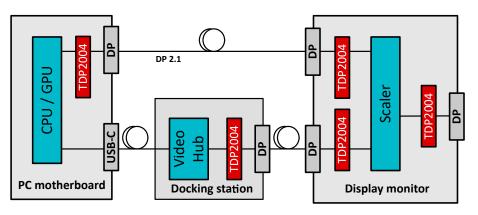


Figure 7-1. Typical Application

7.2.1 DP 2.1 Mainlink Signal Conditioning

The TDP2004 can be used in a PC motherboard or in a docking station or in a display monitor among other applications to boost DisplayPort mainlink signals to increase the reach of the source and sink channel. The following sections outline detailed procedures and design requirements for a typical DP 2.1 application. However, the design recommendations can be used in other use cases.

7.2.1.1 Design Requirements

As with any high-speed design, there are many factors which influence the overall performance. The following list indicates critical areas for consideration during design.

- Length matching on the P and N traces should be done on the single-end segments of the differential pair.
- Use a uniform trace width and trace spacing for differential pairs.
- Place AC-coupling capacitors near the receiver end of each channel segment to minimize reflections.
- AC-coupling capacitors of 220 nF are recommended. Set the maximum body size to 0402 and add a cutout void on the GND plane below the landing pad of the capacitor to reduce parasitic capacitance to GND.
- Surface mount connector is recommended. For through hole connection, back-drill connector vias and signal vias to minimize stub length.
- Use ground reference plane vias for a low inductance path for the return current.



7.2.1.2 Detailed Design Procedure

The TDP2004 provides signal conditioning for four DP mainlink channels. The device is a linear redriver which is agnostic to DP link training. The DP link training negotiation between a display source and sink stays effective through the device. The redriver becomes part of the electrical channel along with passive traces, cables, and other channel elements, resulting in optimum source and sink parameters for best electrical link. Figure 7-2 shows a simplified schematic for DisplayPort application using TDP2004.

DisplayPort side band signals AUXp,n and HPD is bypassed. The link will still have successful link training through TDP2004. An inverted HPD signal can be used to control the device standby operation utilizing the PD pin; however appropriate filtering out of HPD interrupt signals must be provisioned.

In some applications where a micro-controller or other link monitoring device has DP link state information, it can exercise I²C registers of TDP2004 for additional power management.

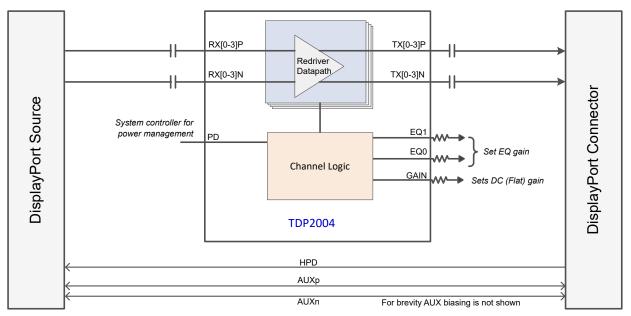
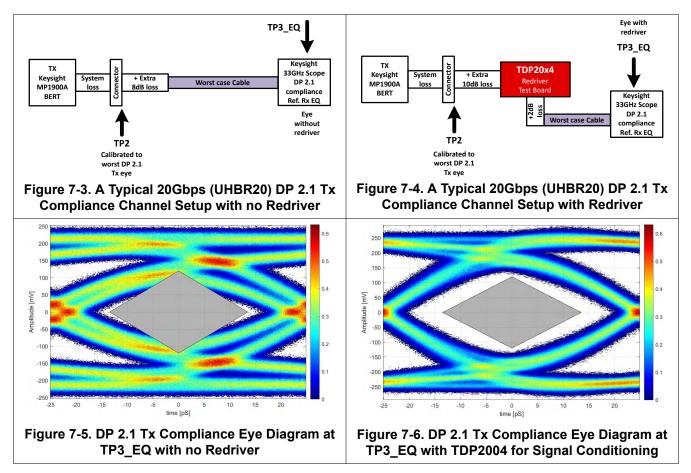


Figure 7-2. Simplified Schematic for DP 2.1 Signal Conditioning in a Source Application such as PC Motherboard in Pin Mode



7.2.1.3 Application Curves

The TDP2004 is a linear redriver that can be used to extend channel reach of a DP link. The redriver can help to pass compliance by removing ISI deterministic jitter at data rates up to 20Gbps (UHBR20). Figure 7-3 - Figure 7-6 shows a typical DP 2.1 Tx compliance channel setup along with compliance Eye Diagrams at TP3_EQ with or without redriver. The comparison of eye diagrams show that TDP2004 can provide signal conditioning by extending horizontal and vertical eye openings that makes a failing eye to pass.



7.3 Power Supply Recommendations

Follow these general guidelines when designing the power supply:

- 1. The power supply should be designed to provide the operating conditions outlined in the recommended operating conditions section in terms of DC voltage, AC noise, and start-up ramp time.
- 2. The TDP2004 does not require any special power supply filtering, such as ferrite beads, provided that the recommended operating conditions are met. Only standard supply decoupling is required. Typical supply decoupling consists of a 0.1 μF capacitor per VCC pin, one 1.0 μF bulk capacitor per device, and one 10 μF bulk capacitor per power bus that delivers power to one or more TDP2004 devices. The local decoupling (0.1 μF) capacitors must be connected as close to the VCC pins as possible and with minimal path to the TDP2004 ground pad.

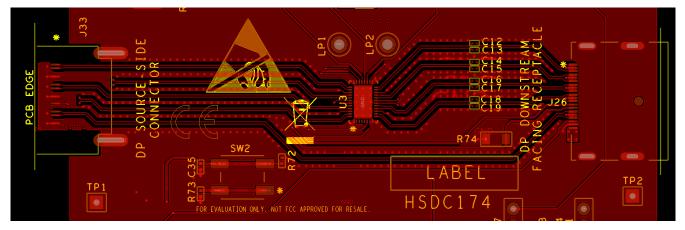


7.4 Layout

7.4.1 Layout Guidelines

The following guidelines should be followed when designing the layout:

- 1. Decoupling capacitors should be placed as close to the VCC pins as possible. Placing the decoupling capacitors directly underneath the device is recommended if the board design permits.
- 2. High-speed differential signals TXnP/TXnN and RXnP/RXnN should be tightly coupled, skew matched, and impedance controlled.
- 3. Vias should be avoided when possible on the high-speed differential signals. When vias must be used, take care to minimize the via stub, either by transitioning through most or all layers or by back drilling.
- 4. GND relief can be used (but is not required) beneath the high-speed differential signal pads to improve signal integrity by counteracting the pad capacitance.
- 5. GND vias should be placed directly beneath the device connecting the GND plane attached to the device to the GND planes on other layers. This has the added benefit of improving thermal conductivity from the device to the board.
- 6. Please refer to land pattern example in the mechanical drawing section for the device thermal pad design recommendation.



7.4.2 Layout Example

Figure 7-7. TDP2004 Layout Example – Sub-Section of TI evaluation board with DP connectors



8 Device and Documentation Support

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

8.3 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

DATE	REVISION	NOTES					
November 2023	*	Initial Release					

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
TDP2004IRNQR	ACTIVE	WQFN	RNQ	40	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TDP2	
IDF2004IRNQR	ACTIVE	WQFN	RINQ	40	3000	KUNS & Gleen	NIFDAU	Level-1-200C-UNLIW	-40 10 65	IDF2	Samples
TDP2004IRNQT	ACTIVE	WQFN	RNQ	40	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TDP2	Somulas
											Samples
TDP2004RNQR	ACTIVE	WQFN	RNQ	40	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TDP2	Samples
											Bumpies
TDP2004RNQT	ACTIVE	WQFN	RNQ	40	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TDP2	Samples
											- Statipies

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and



www.ti.com

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



Texas

*All dimensions are nominal

www.ti.com

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TDP2004IRNQR	WQFN	RNQ	40	3000	330.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004IRNQT	WQFN	RNQ	40	250	180.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004RNQR	WQFN	RNQ	40	3000	330.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004RNQT	WQFN	RNQ	40	250	180.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2



www.ti.com

PACKAGE MATERIALS INFORMATION

13-Dec-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TDP2004IRNQR	WQFN	RNQ	40	3000	367.0	367.0	35.0
TDP2004IRNQT	WQFN	RNQ	40	250	210.0	185.0	35.0
TDP2004RNQR	WQFN	RNQ	40	3000	367.0	367.0	35.0
TDP2004RNQT	WQFN	RNQ	40	250	210.0	185.0	35.0

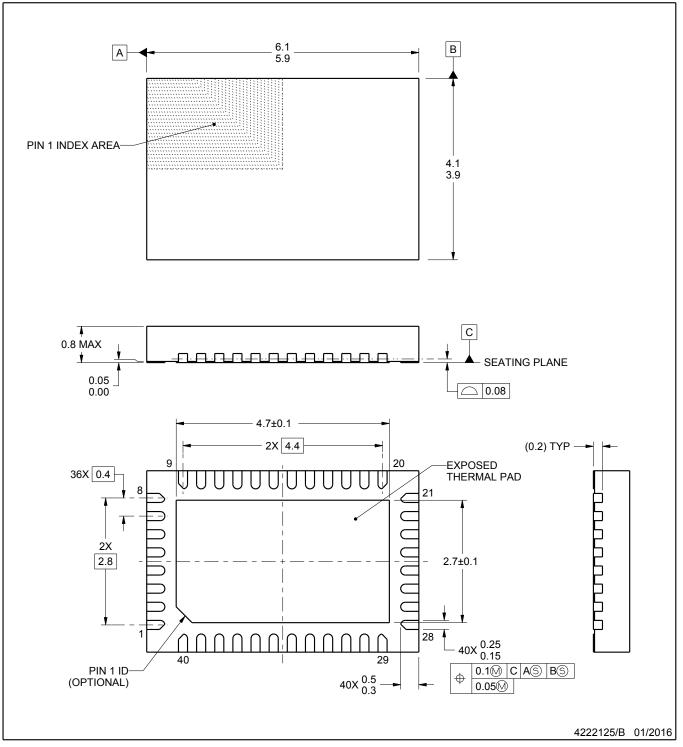
RNQ0040A



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

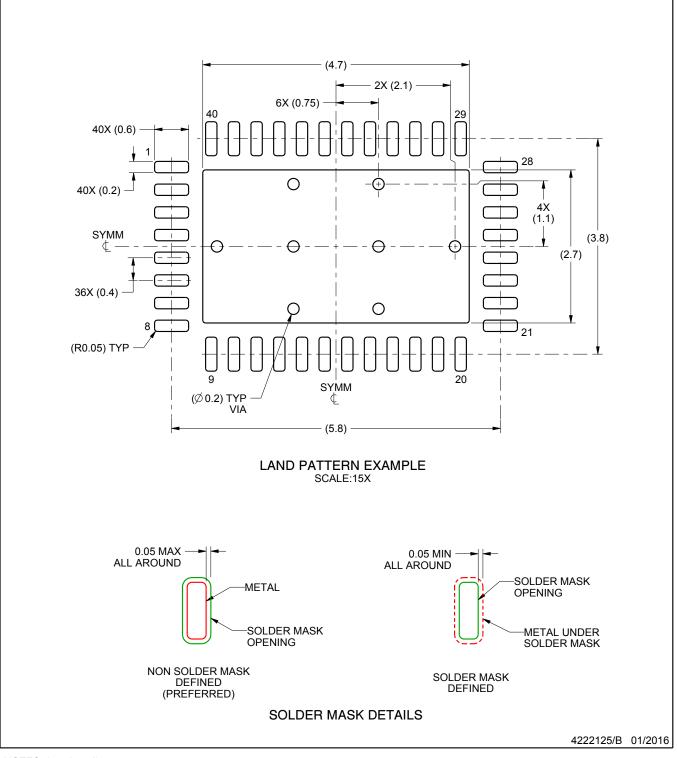


RNQ0040A

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

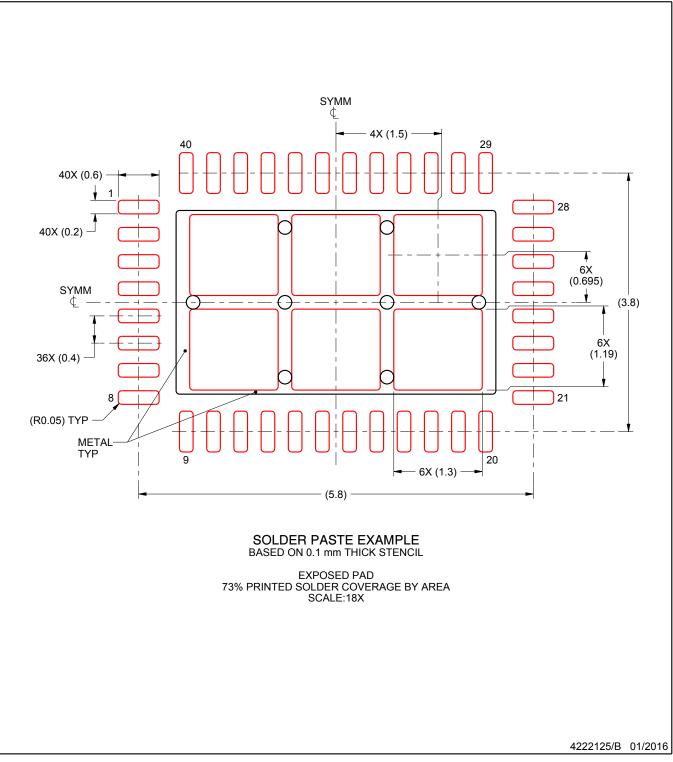


RNQ0040A

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2023, Texas Instruments Incorporated